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Application/Control No.	Applicant(s)/Patent under Reexamination
10/620,180	KEOGH ET AL.
Examiner	Art Unit
David M. Naff	1651

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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